

Notice of References Cited	Application/Control No. 10/679,971		Applicant(s)/Patent Under Reexamination BEST, ROBERT M.	
	Examiner Khoi Nguyen		Art Unit 2132	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,712,704	03-2004	Elliott, Scott	463/43
*	B	US-6,728,379	04-2004	Ishibashi et al.	380/278
*	C	US-6,139,433	10-2000	Miyamoto et al.	463/32
*	D	US-6,238,291	05-2001	Fujimoto et al.	463/44
*	E	US-6,544,126	04-2003	Sawano et al.	463/42
*	F	US-5,632,681	05-1997	Bakoglu et al.	463/44
*	G	US-6,081,785	06-2000	Oshima et al.	705/1
*	H	US-2001/0003714	06-2001	TAKATA et al.	463/40
*	I	US-2003/0177347	09-2003	Schneier et al.	713/151
*	J	US-6,884,171	04-2005	Eck et al.	463/42
*	K	US-2002/0028710	03-2002	Ishihara et al.	463/44
*	L	US-7,130,425	10-2006	Strasser et al.	380/44
*	M	US-2002/0174351	11-2002	Jeong et al.	713/189

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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